Docket No. 29273/502

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT(S):

Hajime KAWANO et al.

SERIAL NO. :

09/315,988

FILED

21 May 1999

FOR

ELECTRON BEAM LITHOGRAPHY SYSTEM

ART UNIT

2881

EXAMINER:

K. Fernandez

ASSISTANT COMMISSIONER

FOR PATENTS

Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97 & § 1.98

SIR:

In conformance with Applicants' duty of disclosure under 37 C.F.R. § 1.56 and § 1.97(c)(1), the references listed on the attached form PTO-1449 are hereby brought to the Examiner's attention.

In compliance with 37 C.F.R. § 1.98, copies of the references are submitted herewith.

Statement of Relevancy

JP 06-333796 A was cited in an Office Action issued on 27 February 2002 by the Japanese Patent Office. (A copy of U.S. Patent No. 5,754,443, which corresponds to said Japanese reference, is enclosed for the Examiner's convenience).

Certification Pursuant to 37 C.F.R. 1.97(e)(1)

The undersigned attorney hereby certifies that the Japanese reference contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

PECTIMED TOS

It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear in the "references cited" on any patent to issue therefrom.

Respectfully submitted,

(Reg. No. 25,951)

Date: 24 May 2002

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Sheet 1 of 1

FORM PTO-1449

INFORMATION DISCLOSURE STATEMENT BY APPLICANT(S)

Atty Docket No.

: 29273/502

Serial No.

: 09/315,988

Applicants

: H. KAWANO et al.

Filed

: 21 May 1999

Group Art Unit

: 2881

Examiner

: K. Fernandez



U.S. PATENT DOCUMENTS

Examiner	Patent	Patent	Name	Class/ Filing
<u>Initial</u>	<u>Number</u>	<u>Date</u>		Subclass Date
	5,754,443	05/19/98	Y. MANABE	364,491

FOREIGN PATENT DOCUMENTS

Examiner <u>Initial</u>	Document <u>Number</u>	<u>Date</u>	Country	Class/ <u>Subclass</u>	Translation <u>Yes</u> <u>No</u>
	06-333796	12/02/94	Japan		ABS:

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner <u>Initial</u>	
EXAMINER	DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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